Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/782,832	HIROTSUNE ET AL.	ET AL.	
Examiner	Art Unit		
TAN X DINH	2653		

SEARCHED					
Class	Subclass	Date	Examiner		
		_			
	·				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-			
	I			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
DATE	EXMR				
11/10/2005	T.D				
					
	•				
	DATE				